



B 8FW

843.41106X00

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicants: K. ASAYAMA, et al.
Application No.: 10/051,056
Filed: January 22, 2002
For: METHOD FOR MANUFACTURING A SEMICONDUCTOR
DEVICE TO PROVIDE A PLURALITY OF TEST ELEMENT
GROUPS (TEGs) IN A SCRIBE REGION (As Amended)
Art Unit: 2829
Examiner: E. T. Pert
CONF. No. 1783
Allowed: September 27, 2004 **Issue Fee Not Yet Paid**

AMENDMENT PURSUANT TO 37 CFR §1.312

MS: ISSUE FEE
Commissioner For Patents
P. O. Box 1450
Alexandria, VA 22313-1450

October 15, 2004

Sir:

Please amend the above-identified application as listed below and as set forth
on the following pages:

Amendments to the Specification; and

Remarks are included following the amendments.